



#### Packaging of MEMS for Aerodynamic Measurements

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#### Robert White<sup>1</sup>, Peter Lewis<sup>2</sup>, Brian Smith<sup>3</sup>

Mechanical Engineering Faculty, Tufts University, r.white@tufts.edu
 Mechanical Engineering Graduate Student, Tufts University & Draper Fellow, phlewis@draper.com
 Member of the Technical Staff, Draper, brsmith@draper.com

#### **Overall Goal**

- Develop MEMS pressure and shear sensor arrays to measure unsteady turbulent boundary layer spectra and quasistatic local shear stress in wind tunnel tests for velocities up to Mach 0.9.
- Achieve a high spatial resolution by using an array-on-a-chip.



64 element microphone array

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16 element shear sensor array

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#### Background - Turbulent Boundary Layer



(1) Steady (time averaged) shear stress measurements are important for total drag measurement.  $\sim$  50% of drag is skin friction for commercial air.

(2) Wavenumber-frequency spectrum of *unsteady* turbulent pressure and shear is important for structural vibrations and acoustic design.

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### **TBL Pressure Fluctuations**

- The stress fluctuations have particular wavenumbers at which most of the energy is concentrated.
- Convecting turbulent stresses (unsteady pressure and shear) are mainly near k=∞/U<sub>c</sub> where U<sub>c</sub> is approximately 0.7U<sub>∞</sub>
- Acoustic pressures are within the circle k<ω/c</li>

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Bull, M. K. "Wall-pressure fluctuations beneath turbulent boundary layers: some reflections on forty years of research" *Journal of Sound and Vibration* (1996), 190(3), pp. 299-315.



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#### **Smallest Scales of Interest**

- The surface roughness should be less than the viscous sublayer thickness, which is on the order of 5 wall units.
- Energy cascades down from the largest scale eddies to the Kolmogorov microscale where the energy is rapidly dissipated. This is the smallest scale of interest.





At  $U_T \approx 250 \text{ m/s}, \ \delta \approx 3-5 \text{ cm} \rightarrow \eta \approx 5 \ \mu \text{m}$ 

See for example, Lofdahl and Gad-el-Hak, Meas. Sci. Tech, 1999Slide 5 © Robert White 2016May 3, 2016



#### Wavenumber-Frequency Spectrum

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#### Advantages of a MEMS sensor array:

• **Fine pitch** to capture high wavenumber turbulent components (convective ridge, maybe eventually the Kolmogorov scales).

• Low surface topology to limit flow disturbance (< 10  $\mu$ m).

• Large dynamic range: pressure: 60 to > 150 dB SPL shear: 0-100 Pa

• Large frequency range (DC to >300 kHz) useful for scale model measuments ( $\lambda$ /L remains constant).

#### Tufts - Microphone Array on a Chip

*Primary feature*: This system micromachines the array together on a single chip.



1 cm

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- 8×8 array (64 elements) on a 1 cm<sup>2</sup> chip
- 0.6 mm diameter elements
- Element pitch is ~1.25 mm center-to-center.
- Microphones can be routed individually (as shown) or connected together in various parallel arrangements to act as larger aperture transducers.

# Packaging



- Current design is packaged in a 4 cm x 4 cm CPGA.
- Package height is 1.1 cm to the bottom of the pins.



- Packaging uses a hybrid CPGA package and wirebonding.
- The first step is to partially fill the cavity with potting epoxy.
- The epoxy is milled down using a Roland MDX40A milling machine.





Epoxy is milled down to create a pocket to set the chip height and center the chip.



- The edge of the die is protected by hand-painting on additional epoxy.
- This step was added to avoid shorting problems where the wirebonds would touch the edge of the die which is bare silicon.
- This step is difficult and is a source of failure due to either too much or too little epoxy.

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Epoxy hand painted on edge to cover the corner.

- Wirebonds are used to make the connections. These are 1 mil gold ball bonds.
- The largest cause of microphone failures is shorting of the wirebond to the silicon at the edge of the die.







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# **Diaphragm Vent Holes**

- Due to misalignment during fabrication, the diaphragm vent holes were larger than designed.
- The sensor and wirebonds are then fully coated in Parylene-C, a pinhole free vapor phase deposited polymer that can act as a moisture barrier.



• The Parylene also allows control of the size of the vent holes in the diaphragm.

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# Parylene Coating – Step 4

- Acoustic calibration data shows the recovery of the low frequency sensitivity as the vent hold diameter is reduced by subsequent Parylene depositions.
- Each layer deposited here was approximately 500 nm thick.



- In the final step, potting epoxy is used to fill the cavity and cover the wirebonds.
- The filling epoxy is done in multiple steps with cures in between until a flat top surface is achived.





# Surface Topology

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- Surface topology due to wirebonds is 100 microns.
- Chip to package topology is 25 microns.
- Surface roughness from package to tallest feature is on the order of 125 microns.

## Yield

- Microphone yield is tested by observing the distortion when the microphone is driven electrostatically.
- A 3<sup>rd</sup> harmonic distortion of worse than -60 dB is considered a failure.



 For this recently packaged device, 25/64 microphones fail (39%). This is primarily due to shorts between the wirebonds and the silicon die corner.

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## **Aerosol Jet Printing**

- To address this problem, an aerosol jet printing (AJP) method was used to print polyimide along the edge of the die.
- The primary advantage of AJP for this application is the standoff distance, which is much larger than inkjet.

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J. Chou, M. McAllister, and P. Schottland, "Aerosol Jet Printable Metal Conductive Inks, Glass Coated Metal Conductive Inks and UV-curable Dielectric Inks and Methods of Preparing and Printing the Same," 2014.

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# Polyimide Insulation by AJP

- NeXolve Corin XLS
   Polyimide ink in an Optomec
   300 printing system.
- Two layers were printed, 150 um wide lines 50 um in from the die edge.
- Cured in air in an oven overnight at 130 C (13 hours).
- Gold wirebonds were used as before.





### Improved Yield



• With the AJP printed insulation, the number of bad microphones drops to 9/64 (14%) on Chip #1, and 4/64 (6%) on Chip #2.



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- First, Armstrong C-7
   epoxy was hand applied
   along the edge of the die
   to provide a fillet
   between the die and the
   package.
- NeXolve Corin XLS Polyimide ink was then AJP printed along the corner and cured, identically as done with the previous chip.

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- Interconnects were then printed using NovaCentrix HPS-030AE1 Silver Flake Ink in the Optomec 300 printing system.
- All interconnects taken from CAD file; alignment to chip and package corners.
- Sintered 19.5 hours for 130°C in oven.





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- Interconnect lines are approximately 130 um wide.
- Some overspray is observed.





 White light interferometry image shows approximately 4 um high silver ink lines.

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# Yield with AJP Silver Ink Interconnect

With this first attempt at AJP silver ink interconnect:

> 37/64 (58%) of elements are successful

> 25/64 (39%) of elements are shorted

2/64 (3%) appear unconnected

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#### Conclusions

- Packaging topology of 0.13 mm is too high for aeroacoustic MEMS measurement applications under the turbulent boundary layer.
- Aerosol Jet Printing (AJP) was explored to improve yield and reduce MEMS-package interconnect topology.
- AJP polyimide insulation was successful at reducing defective elements from 39% to 6% by preventing shorting of wirebonds to the silicon die corner.
- AJP silver ink interconnects were successfully printed, and on our first module 58% of the microphone elements are active.
- 39% of the microphones are shorted to the substrate. This may be due to pinholes or incomplete coverage in the AJP polyimide at the chip edge, or possibly due to overspray.



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